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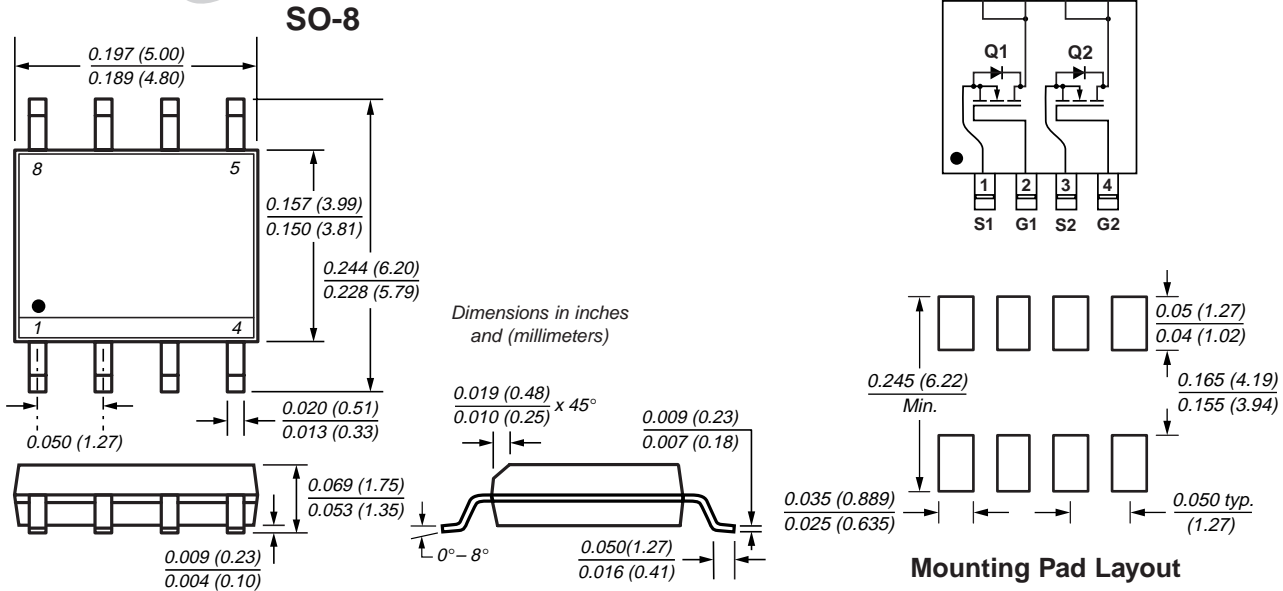
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Dual N-Channel Enhancement-Mode MOSFET

Low $V_{GS(th)}$ V_{DS} 20V $R_{DS(on)}$ 30mΩ I_D 6.0A

TRENCH GENFET®



Mechanical Data

Case: SO-8 molded plastic body
Terminals: Leads solderable per MIL-STD-750, Method 2026
High temperature soldering guaranteed: 250°C/10 seconds at terminals
Mounting Position: Any **Weight:** 0.5g

Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Fast Switching
- Logic Level
- Ideal for Li ion battery pack applications

Maximum Ratings and Thermal Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 10	
Continuous Drain Current $T_J = 150^\circ\text{C}^{(1)}$	I_D	$T_A = 25^\circ\text{C}$ 6.0	A
		$T_A = 70^\circ\text{C}$ 4.8	
Pulsed Drain Current	I_{DM}	20	
Continuous Source Current (Diode Conduction) ⁽¹⁾	I_S	1.7	
Maximum Power Dissipation ⁽¹⁾	P_D	$T_A = 25^\circ\text{C}$ 2.0	W
		$T_A = 70^\circ\text{C}$ 1.3	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150	$^\circ\text{C}$
Maximum Junction-to-Ambient ⁽¹⁾ Thermal Resistance	$R_{\theta JA}$	62.5	$^\circ\text{C/W}$

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Electrical Characteristics (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = 250μA	20	–	–	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	0.6	–	–	V
Gate-Body Leakage	I _{GSS}	V _{DS} = 0V, V _{GS} = ±8V	–	–	±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20V, V _{GS} = 0V	–	–	1	μA
		V _{DS} =20V, V _{GS} =0V, T _J =55°C	–	–	5	
On-State Drain Current ⁽²⁾	I _{D(on)}	V _{DS} ≥ 5V, V _{GS} = 4.5V	20	–	–	A
Drain-Source On-State Resistance ⁽²⁾	R _{DS(on)}	V _{GS} = 4.5V, I _D = 6A	–	22	30	mΩ
		V _{GS} = 2.5V, I _D = 5.2A	–	28	40	
Forward Transconductance ⁽²⁾	g _{fs}	V _{DS} = 10V, I _D = 6A	–	24	–	S

Dynamic

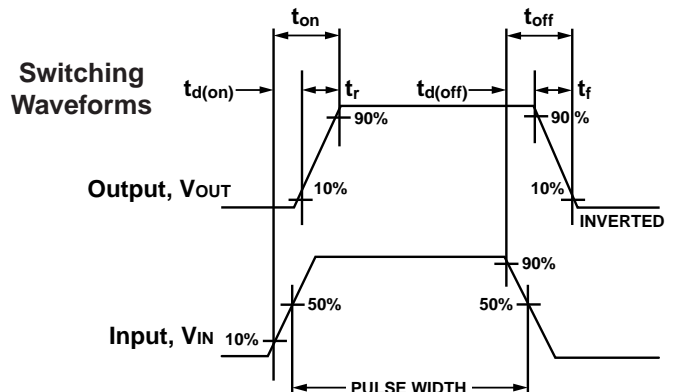
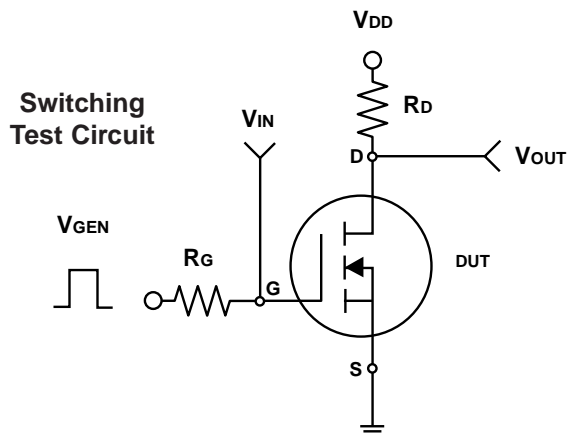
Total Gate Charge	Q _g	V _{DS} = 10V, V _{GS} = 4.5V I _D = 6A	–	13	40	nC
Gate-Source Charge	Q _{gs}		–	2.2	–	
Gate-Drain Charge	Q _{gd}		–	3	–	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 10V, R _L = 10Ω I _D ≈ 1A, V _{GEN} = 4.5V R _G = 6Ω	–	11	60	ns
Rise Time	t _r		–	15	140	
Turn-Off Delay Time	t _{d(off)}		–	43	140	
Fall Time	t _f		–	22	60	
Input Capacitance	C _{iss}	V _{GS} = 0V	–	1240	–	pF
Output Capacitance	C _{oss}	V _{DS} = 10V	–	200	–	
Reverse Transfer Capacitance	C _{rss}	f = 1.0MHz	–	120	–	

Source-Drain Diode

Diode Forward Voltage ⁽²⁾	V _{SD}	I _S = 1.7A, V _{GS} = 0V	–	0.7	1.3	V
Source-Drain Reverse Recovery Time	t _{rr}	I _F = 1.7A, di/dt = 100A/μs	–	–	100	ns

Notes: (1) Surface mounted on FR4 board, t ≤ 10 sec.

(2) Pulse test; pulse width ≤ 300 μs,
duty cycle ≤ 2%



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Ratings and Characteristic Curves ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Fig. 1 – Output Characteristics

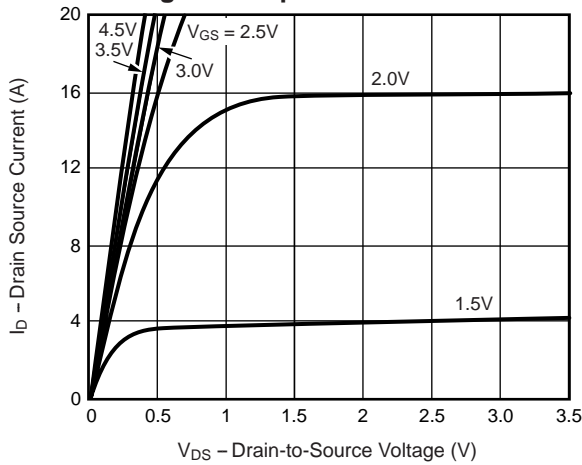


Fig. 2 – Transfer Characteristics

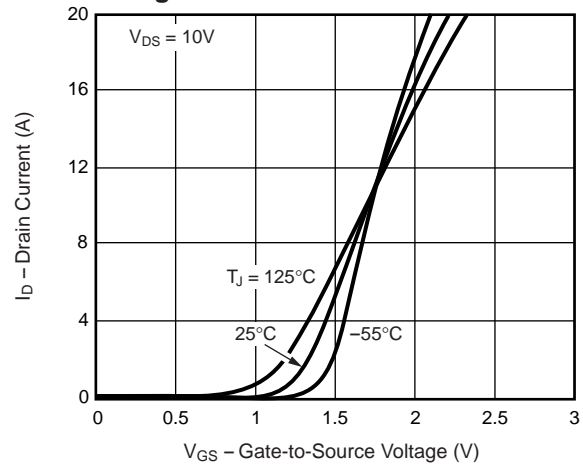


Fig. 3 – Threshold Voltage vs. Temperature

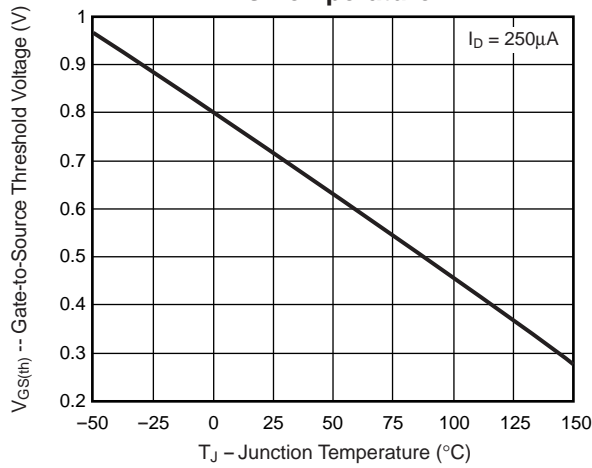


Fig. 4 – On-Resistance vs. Drain Current

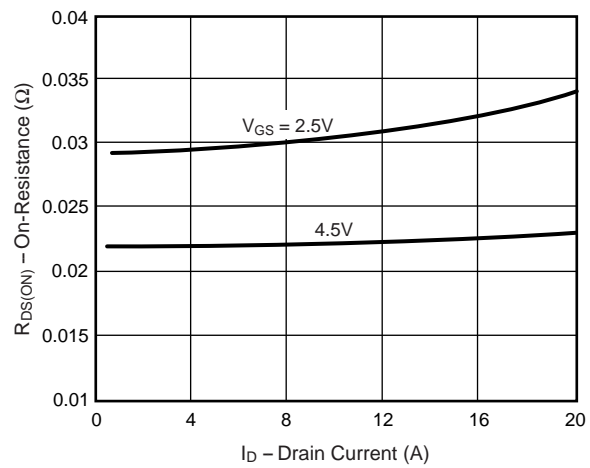
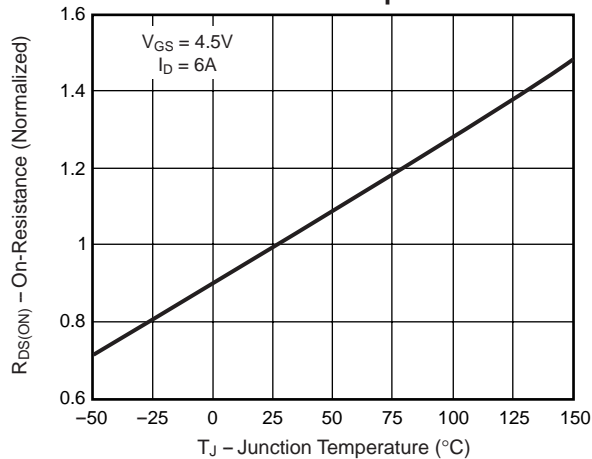


Fig. 5 – On-Resistance vs. Junction Temperature



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Fig. 6 – On-Resistance vs. Gate-to-Source Voltage

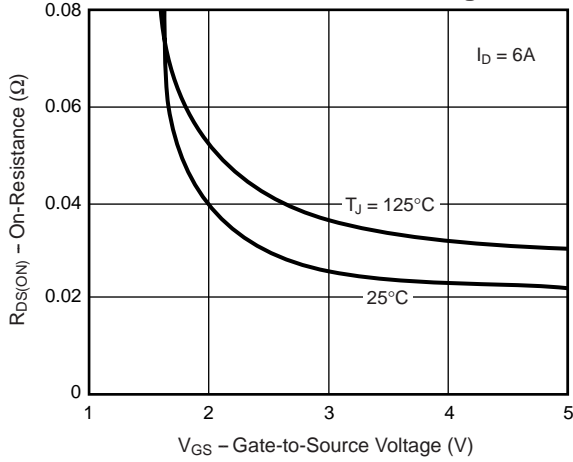


Fig. 7 – Gate Charge

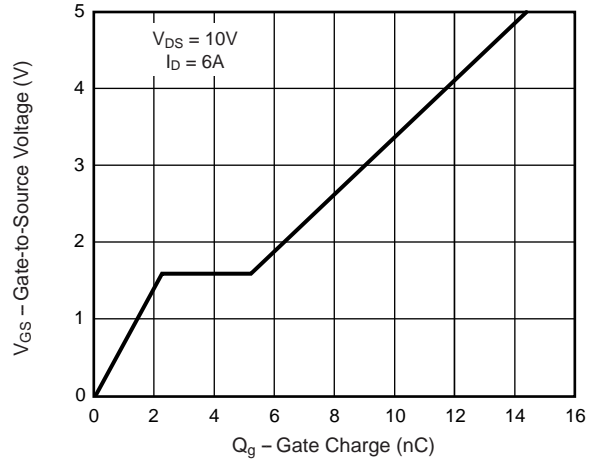


Fig. 8 – Capacitance

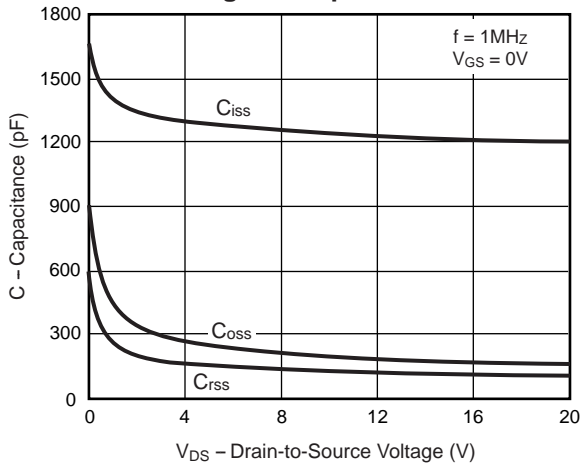
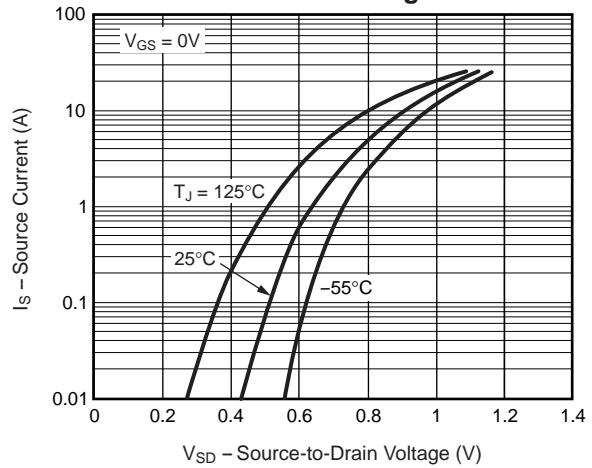


Fig. 9 – Source-Drain Diode Forward Voltage



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Fig. 10 – Breakdown Voltage vs. Junction Temperature

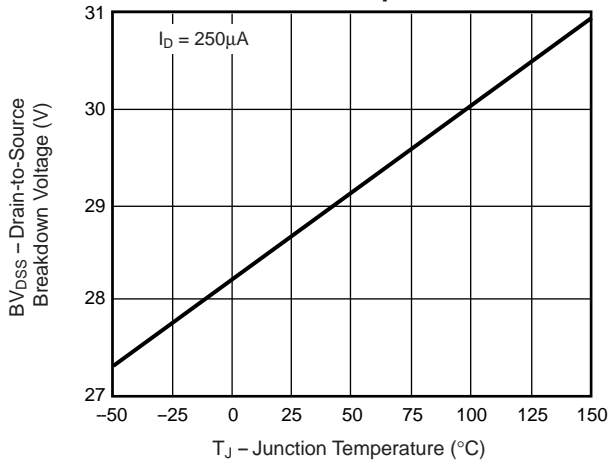


Fig. 11 – Thermal Impedance

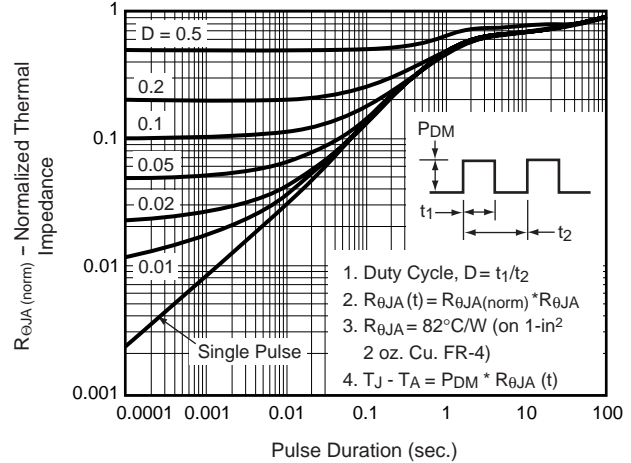


Fig. 12 – Power vs. Pulse Duration

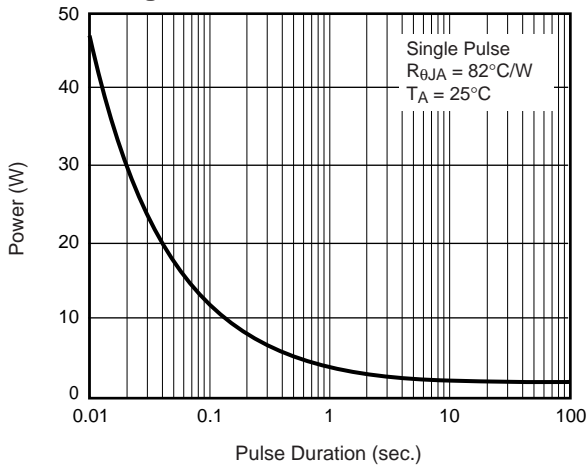


Fig. 13 – Maximum Safe Operating Area

